

Search Notes

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Examiner

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Applicant(s)/Patent under
Reexamination

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3652

SEARCHED

Class	Subclass	Date	Examiner
updated	search	3/7/2006	PTC
24	68CD	3/7/2006	PTC
119	792		
	793	3/7/2006	PTC

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR